# BUK9K31-100L Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

Product data sheet

# 1. General description

Dual N-channel logic level MOSFET in an LFPAK56D (Dual Power-SO8) package. This product has been designed and qualified to AEC-Q101 standard for use in high performance automotive applications.

## 2. Features and benefits

- Dual MOSFET two silicon dies in one LFPAK56D package for significant space saving
- Trench12 MOSFET technology
- Efficient switching with soft body-diode recovery
- Automotive qualified to AEC-Q101 at 175 °C
- Side-wettable flanks for robust solder joints and automatic optical inspection

## 3. Applications

- 12 V 24 V and 48 V automotive systems
- Motor, lighting, and solenoid control
- Transmission control
- LED lighting
- Circuit protection

## 4. Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Limiting values FET1 and FET2							
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		-	-	100	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	[1]	-	-	24	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	-	43	W
Static characte	ristics FET1 and FET2						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ °C}; Fig. 11$		13.4	25	31.7	mΩ
Dynamic characteristics FET1 and FET2							
$Q_{GD}$	gate-drain charge	$I_D = 5 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 5 \text{ V};$ $T_j = 25 \text{ °C}; Fig. 13; Fig. 14$		0.8	2.8	6	nC

<sup>[1] 24</sup> A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.



## Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

# 5. Pinning information

**Table 2. Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1	8 7 6 5	
2	G1	gate1		D1 D1 D2 D2
3	S2	source2		
4	G2	gate2		
5	D2	drain2		
6	D2	drain2		
7	D1	drain1		S1 G1 S2 G2
8	D1	drain1	LFPAK56D; Dual LFPAK (SOT1205)	mbk725

# 6. Ordering information

**Table 3. Ordering information** 

Type number	Package	ackage				
	Name	Description	Version			
BUK9K31-100L		plastic, single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

## 7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9K31-100L	9311HL

# 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Tj = 25 °C unless otherwise stated.

Symbol	Parameter	Conditions		Min	Max	Unit
Limiting value	s FET1 and FET2					
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		-	100	V
$V_{GS}$	gate-source voltage		[1]	-20	20	V
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	43	W
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	[2]	-	24	Α
		V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; <u>Fig. 2</u>		-	17	А
I <sub>DM</sub>	peak drain current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 °C$ ; Fig. 3		-	98	А
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drain o	liode FET1 and FET2					
Is	source current	T <sub>mb</sub> = 25 °C		-	24	А
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$		-	98	А

#### Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

Symbol	Parameter	Conditions		Min	Max	Unit
Avalanche ruggedness FET1 and FET2						
E <sub>DS(AL)S</sub>	non-repetitive drain- source avalanche energy	$I_D$ = 8.3 A; $V_{sup}$ ≤ 100 V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped; $t_{AL}$ = 75 μs; Fig. 4	[3] [4]	-	40.7	mJ
I <sub>AS</sub>		$V_{sup} = 100 \text{ V; } V_{GS} = 5 \text{ V; } T_{j(init)} = 25 \text{ °C;}$ $R_{GS} = 50 \Omega; \frac{\text{Fig. 4}}{}$	[3] [4]	-	8.3	А

- [1] Refer to application note AN90001 for further information.
- [2] 24 A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [3] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [4] Refer to application note AN10273 for further information.

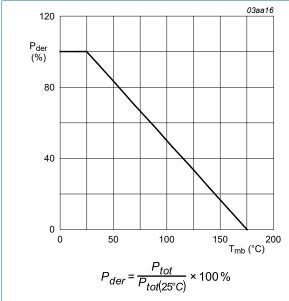
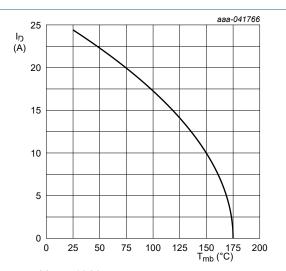
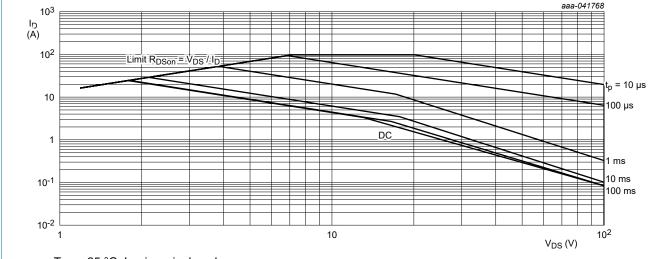


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$  24 A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

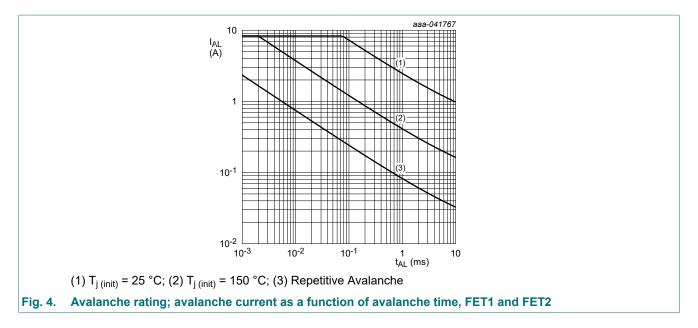
Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2



 $T_{mb}$  = 25 °C;  $I_{DM}$  is a single pulse

Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage, FET1 and FET2

## Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D



## 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	2.11	3.45	K/W

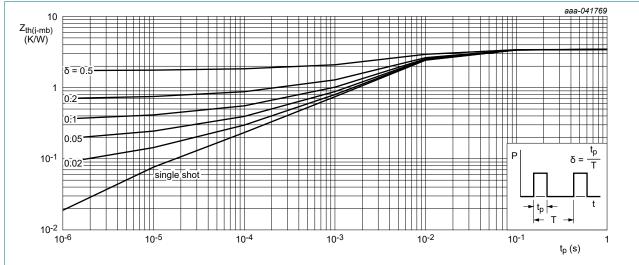


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FFT2

## Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

## 10. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
-	acteristics FET1 and FET2		101111	יאָרי	IIIUA	Oint
V <sub>(BR)DSS</sub>	drain-source	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 25 °C	100	118.3		V
▼(BR)DSS	breakdown voltage	$I_D = 250 \mu\text{A},  \text{V}_{GS} = 0 \text{V},  I_j = 25 \text{C}$ $I_D = 250 \mu\text{A};  \text{V}_{GS} = 0 \text{V};  T_i = -40 \text{°C}$	92	112	_	V
		$I_D = 250 \mu\text{A},  V_{GS} = 0  \text{V},  I_j = -40  \text{C}$ $I_D = 250 \mu\text{A};  V_{GS} = 0  \text{V};  T_i = -55  \text{°C}$	90	110		V
\ /	gata aguraa thraabald	•	1.4	1.7	2.05	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 0.05 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ Fig. 9; Fig. 10		1.7	2.05	
		$I_D = 0.05 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 10	0.5	-	-	V
		$I_D = 0.05 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ Fig. 10	-	-	2.3	V
DSS	drain leakage current	V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	0.006	1	μA
		V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 125 °C	-	2	100	μA
		V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 175 °C	-	25	500	μA
GSS	gate leakage current	V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	2	100	nA
		V <sub>GS</sub> = -20 V; V <sub>DS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	- 2 100 r 13.4 25 31.7 r 19.7 38.5 51 r 21.5 42.3 56.3 r	nA	
R <sub>DSon</sub>	drain-source on-state	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A; T <sub>i</sub> = 25 °C; <u>Fig. 11</u>	13.4	25	31.7	mΩ
20011	resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 100 °C; Fig. 12	19.7	38.5	51	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 125 °C; Fig. 12	21.5	42.3	56.3	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 5 A; $T_j$ = 175 °C; Fig. 12	26.2	53	72.5	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ °C}; Fig. 11$	21.7	31	47	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 5 \text{ A}; T_j = 100 °C;$ Fig. 12	32	47.7	75.5	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 5 \text{ A}; T_j = 125 ^{\circ}\text{C};$ Fig. 12	34.8	52.4	83.5	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 5 \text{ A}; T_j = 175 ^{\circ}\text{C};$ Fig. 12	42.4	65.7	107.6	mΩ
R <sub>G</sub>	gate resistance	f = 1 MHz; T <sub>i</sub> = 25 °C	0.8	1.6	3.2	Ω
	naracteristics FET1 and FE	,				
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 5 A; V <sub>DS</sub> = 50 V; V <sub>GS</sub> = 5 V; T <sub>i</sub> = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	5.4	10.9	16.3	nC
		I <sub>D</sub> = 5 A; V <sub>DS</sub> = 50 V; V <sub>GS</sub> = 10 V; T <sub>i</sub> = 25 °C; Fig. 13; Fig. 14	10.3	20.7	31	nC
Q <sub>GS</sub>	gate-source charge	$I_D = 5 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 5 \text{ V};$	2.2	3.7	5.2	nC
$Q_{GD}$	gate-drain charge	T <sub>j</sub> = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	0.8	2.8	6	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	I <sub>D</sub> = 5 A; V <sub>DS</sub> = 50 V; T <sub>j</sub> = 25 °C; <u>Fig. 13;</u> Fig. 14	-	2.8	-	V
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz;	832	1386	1940	pF
Soss	output capacitance	$T_j = 25 \text{ °C}; \frac{\text{Fig. 15}}{\text{Fig. 15}}$	196	326	521	pF
C <sub>rss</sub>	reverse transfer capacitance		12	30	49	pF

#### Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 50 \text{ V}; R_L = 10 \Omega; V_{GS} = 5 \text{ V};$		-	9.7	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 °C$		-	9.2	-	ns
$t_{d(off)}$	turn-off delay time			-	14.5	-	ns
t <sub>f</sub>	fall time	1		-	9.1	-	ns
Source-dra	in diode FET1 and FET2				•		
$V_{SD}$	source-drain voltage	$I_S = 5 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; Fig. 16		-	0.83	1	V
t <sub>rr</sub>	reverse recovery time	$I_S = 5 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ;		-	42	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 50 V; T <sub>j</sub> = 25 °C; <u>Fig. 17</u>		-	29	-	nC

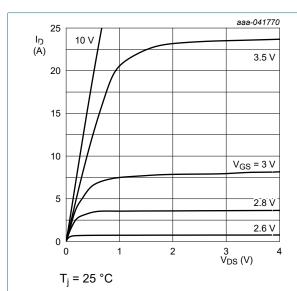


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values, FET1 and FET2

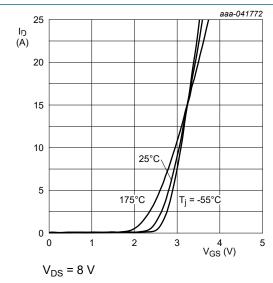


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values, FET1 and FET2

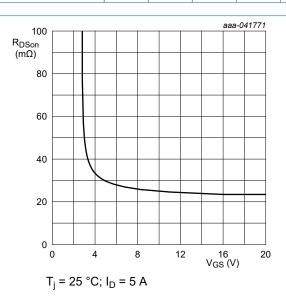


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values, FET1 and FET2

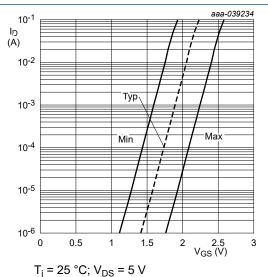


Fig. 9. Sub-threshold drain current as a function of gate-source voltage, FET1 and FET2

#### Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

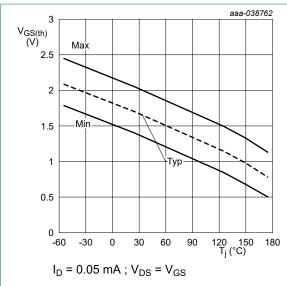


Fig. 10. Gate-source threshold voltage as a function of junction temperature, FET1 and FET2

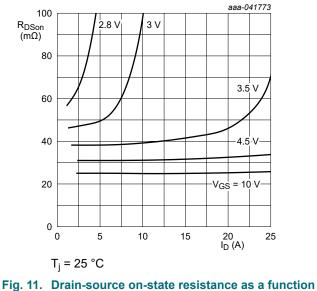


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

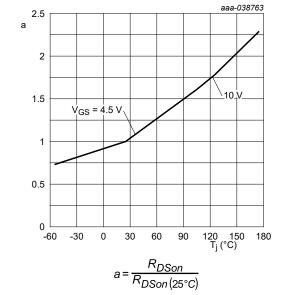


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

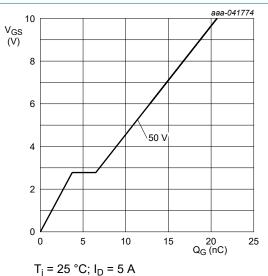


Fig. 13. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

## Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

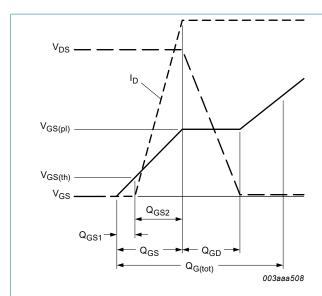


Fig. 14. Gate charge waveform definitions

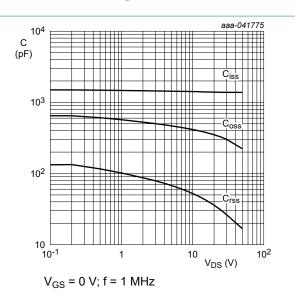


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2

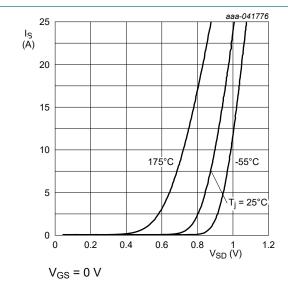


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values, FET1 and FET2

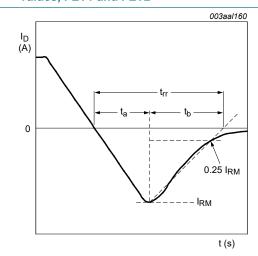


Fig. 17. Reverse recovery timing definition

## Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

# 11. Package outline

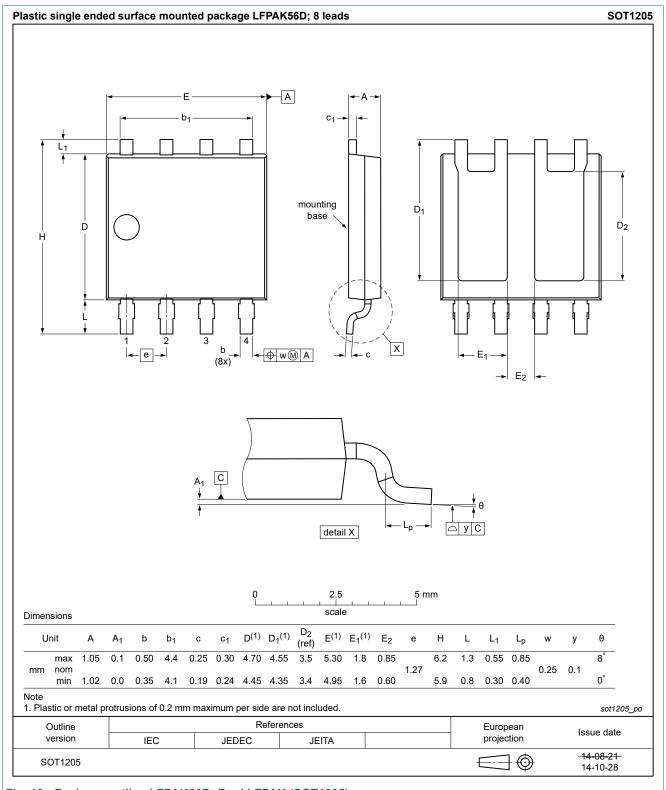


Fig. 18. Package outline LFPAK56D; Dual LFPAK (SOT1205)

#### Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

## 12. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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## Dual N-Channel 100V, 31 mOhm logic level MOSFET in LFPAK56D

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